# **Electronic Supplemental Information**

Part 1 – Angular cross-correlation



SI-1: Definition of the angular cross-correlation.  $\Phi$  denotes the azimuthal angle and  $\Delta$  the angle between two points on a scattering intensity annulus.

Fig. SI-1 shows a typical two-dimensional scattering pattern. The definition of the angular cross-correlation function for such a pattern at fixed wave vector transfer Q is [1,2]:

$$C(Q,\Delta) = \frac{\langle I(Q,\Phi)I(Q,\Phi+\Delta)\rangle_{\Phi} - \langle I(Q,\Phi)\rangle_{\Phi}^{2}}{\langle I(Q,\Phi)\rangle_{\Phi}^{2}}.$$
 (SI1)

Herein,  $\Delta$  denotes the angle between two points on an intensity annulus I(Q) with radius Q. For these the cross-correlation is computed by taking the product of all points at given angle  $\Phi$  on the annulus that are separated by  $\Delta$ .  $\langle \cdot \rangle_{\Phi}$  denotes the angular average over such an annulus.

## Part 2 – Superlattice structures AB<sub>2</sub> and AB<sub>13</sub>



 $SI-2 - AB_2$  structure and  $AB_{13}$  structure.

Binary mixtures of colloids can form crystals with superlattice structures. Common superlattice structures are the  $AB_2$  and  $AB_{13}$  structures (Fig. SI-2). 'A' denotes the large particle species, 'B' the small one.

The hexagonal  $AB_2$  structure consists of a hexagonal closed packing of large particles. The small particles form planar rings filling the holes between the larger particles [3].

In the  $AB_{13}$  structure, the large particles form a simple cubic structure. Within this cube, a body-centered small particle is located which is surrounded by 12 other small particles in an icosahedral structure [3].

The stability of these superlattices depends on the radius ratio  $\alpha$ . For 0.425 <  $\alpha$  < 0.60, the AB<sub>2</sub> structure is stable, and for 0.485 <  $\alpha$  < 0.62, the AB<sub>13</sub> structure is stable [4]. As the radius ratio of the silica particles used was  $\alpha$  = 0.58, both structure are expected to be present within the colloidal film.

## Part 3 – Results of a binary colloid film with X = 0.89

In the following the scanning SAXS and XCCM results on a dried colloidal film with particle size ratio  $\alpha$  = 0.58 and mixing ratio X = 0.89 are presented. The experimental conditions were the same as described in the main part.



### Part 3.1 – Intensity maps for X = 0.89



Fig. SI-3 shows the scanning map of the scattering intensity of the  $Q_1$  – partition. Clearly visible are the sharp edges of the dried colloidal film. The strongest scattering intensity is detected for a pronounced stripe in the upper part close to the edge of the film. In contrast, for the region below a continuous reduction of the scattering intensity is present. This points towards a particle density gradient in the film (indicated by the red arrow).





Compared to the  $Q_1$  - partition, the scattering intensity of the  $Q_2$  – partition (Fig. SI-4) is in general stronger because the small particle species is dominating within the sample. In contrast to the intensity map at  $Q_1$ , the intensity gradient is weaker in the film. This suggests that the large silica particles are mainly contained in the stripe-like region close to the upper film edge. The small particles are distributed everywhere in the film. Thus, for this sample particle segregation within the drying process took place.

#### Part 3.2 – Cross-correlation maps for X = 0.89

Figures SI-5 to SI-10 display the XCCM maps for l = 2, 4 and 6 for both Q-partitions. As for the X = 0.66 sample, a strong l = 2 contribution is present at the film edge at  $Q_1$ . For the other parts of this film, the l = 4 contribution is stronger than the l = 2 contribution. The region where the large particle species is more dominantly present, i.e. the stripe region, has a reduced four-fold order compared to the other parts of the sample. Notable is one ordered region containing only the large particles (Fig. SI-5 to SI-7 in the upper right corner).



 $SI-5 - XCCM map Q_1, I = 2.$ 



 $SI-6 - XCCM map Q_1, I = 4.$ 

![](_page_5_Figure_0.jpeg)

SI-7 – XCCM map  $Q_1$ , I = 6.

![](_page_5_Figure_2.jpeg)

SI-8 – XCCM map  $Q_2$ , I = 2.

![](_page_6_Figure_0.jpeg)

SI-9 – XCCM map  $Q_2$ , I = 4.

![](_page_6_Figure_2.jpeg)

SI-10 – XCCM map  $Q_2$ , I = 6.

Part 3.3 – Map sections for X = 0.89

![](_page_7_Figure_1.jpeg)

SI-11 – Map section for  $Q_1$ . The I = 2 component, being only an indicator for the film edges, is not shown.

![](_page_7_Figure_3.jpeg)

SI-12 – Map section for  $Q_2$ .

Fig. SI-11 and SI-12 show the results of the sections of the intensity and XCCM maps for both *Q*-partitions along the red arrow (see Fig. SI-3) averaging along the full film size. For  $Q_1$  the prounced stripe as well as the decreasing particle density are visbile from the intensity curve. In case of the cut for the  $Q_2$  map, the scattering intensity is neither that strong at the stripe region nor is the particle gradient that strong indicating a more homogenous distribution of small particles.

For the  $Q_1$ -partition the l = 4 contribution is the most dominant Fourier component. It is reduced in the stripe-region indicating a reduced order due to the high fraction of large silica particles. The l = 4 curve is nearly constant along the other part of the film for  $Q_1$ . The other Fourier components studied, i.e. l = 6-10, have reduced amplitudes of similar values and show small maxima at both the stripe region and within the small particle region.

In contrast, for the  $Q_2$  map the l = 2 Fourier component is the strongest component. It exhibits a minimum in the stripe region and is nearly constant within the other part of the film. The l = 4 component has a smaller amplitude but a similar shape. The l = 6 component is nearly constant. This finding is similar to that for the film with X = 0.66.

### References

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